

Photograph No.1 Setup for spurious emission field strength measurements in the anechoic chamber below 30 MHz



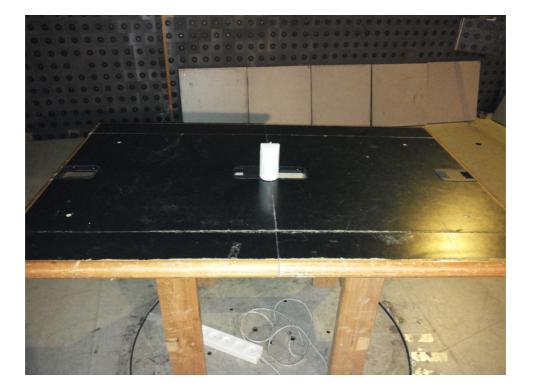
Photograph No.2 Setup for carrier field strength, spurious emission field strength measurements in the anechoic chamber in 30 – 1000 MHz range





Photograph No.3 Setup for spurious emission field strength measurements in the anechoic chamber above 1000 MHz

Photograph No.4 Setup for spurious emission field strength measurements in the anechoic chamber, EUT close view





Photograph No.5 Setup for OBW and periodic operation measurements